A Metric for Measuring the Abstraction Level of Design Patterns

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Abstract. The abstraction level of the problem treated by a design pattern has wide variety, from architecture to near implementation. There is no objective metric indicating the abstraction level of the problems addressed by patterns. Thus, it is difficult to understand the abstraction level of each pattern and to position a new pattern. In this paper, a metric is proposed. It indicates relative abstraction level of each pattern’s problem. We propose a metric obtained from inter-pattern relationships. We also propose a visualization method for the metric. Using such metric, we aim to help developers on easily understanding the abstraction level of each pattern and therefore to better decide about its usefulness for the problem at hand.

1 Introduction

A software pattern is a proven solution to recurrent problems that appear in the context of software development [1]. Describing the knowledge of experienced developers promotes sharing and reusing their knowledge. Many authors published many patterns, and most of the patterns have relationships to other patterns. A Pattern catalog is a set of patterns that are related to each other.

In the design phase, developers break the system down gradually. Initially, the system has higher abstraction level, and is independent from details in design and implementation. Near the end of development, the system has lower abstraction level, and depends on a concrete language and environment. There are software patterns addressing problems for each phase. A pattern have an abstraction level according to the system’s abstraction level.

Developers should select patterns according to their development phase because the pattern mismatched with the system’s abstraction level is not effective. Therefore, developers need to know the abstraction levels of patterns. In the phase of basic design, developers will not be aware of idioms, and in the phase of implementation, developers will not be aware of architectural patterns. The patterns mismatching current development phase may make developers confused. However, abstraction levels of patterns are different even if they belong
to a same pattern catalog. Developers cannot clearly classify some patterns into architectural patterns, design patterns, or idioms.

For example, let’s consider Gang of Four (GoF)’s object-oriented design patterns [2] and PoSA’s patterns [1]. The GoF’s design patterns deal with the problems at the granularity of class design, and PoSA’s patterns deal problem at the granularity of system architecture design. However, for example, GoF’s Interpreter pattern is near an architectural pattern because it uses many other patterns directly and/or indirectly in its solution. It can be thought that the Model-View-Controller (MVC) pattern [3] [1] is near a design pattern because it treats individual applications. As in the above situations, it can be difficult for developers to select patterns fitting into considering level of abstraction. If there is a metric that position the Interpreter pattern near architectural patterns, developers can discuss whether to use it or not. However, actually, there is no objective metric capable to indicate that.

In this paper, we propose a metric that indicates the relative abstraction level of each pattern in a set of patterns. The proposed metric is based on partially-ordered relationships between two patterns, which aims to assist on understanding pattern’s abstraction level, classifying patterns, and selecting patterns to solve faced problems.

2 A metric measuring abstraction level of design patterns

There is a wide variation in software design’s abstraction level from architecture to detailed design near implementation. Developers focus on dividing a system into subsystems at first. Next, they focus on the design of each subsystem, modules, and implementation. There are software patterns in each abstraction level of software design.

Most of patterns have one or more inter-pattern relationships. Authors of patterns often describe relationships in Related Patterns sections. Table 1 lists some examples of inter-pattern relationships. The Partially-ordered column shows whether each relationship is partially-ordered or not. For example, the structure of Interpreter pattern’s syntax tree would be designed using Composite pattern. That is a Uses relationship. Some inter-pattern relationships exist across different pattern catalogs. As another example, MVC pattern uses Observer pattern.

In this metric, we use only Uses, Refines, and Provides context relationships, i.e., the partially-ordered relationships shown on Table 1. The proposed metric has two principals below:

- Patterns that use other patterns, patterns which are more generalized, and patterns that is applied before other patterns have higher abstraction level.
- Patterns used by other patterns, patterns that are more specified, and patterns that are applied after other patterns have lower abstraction level.

In the following, we will present an intuitive explanation and a formal definition.
Table 1. A list of inter-pattern relationships

<table>
<thead>
<tr>
<th>Kind of relationship</th>
<th>Description</th>
<th>Partially-ordered</th>
</tr>
</thead>
<tbody>
<tr>
<td>Similar to [4, 5]</td>
<td>Pattern X is similar to Pattern Y.</td>
<td>No</td>
</tr>
<tr>
<td>Uses [4–6]</td>
<td>Pattern X uses another pattern Y in its solution.</td>
<td>Yes</td>
</tr>
<tr>
<td>Refines [1, 5], Specific [6]</td>
<td>Pattern Y provides more specific solution than pattern X.</td>
<td>Yes</td>
</tr>
<tr>
<td>Combinable [1]</td>
<td>Pattern X and Pattern Y can be combined.</td>
<td>No</td>
</tr>
<tr>
<td>Variation [1]</td>
<td>Pattern Y is pattern X with some changes of Y’s solution.</td>
<td>No</td>
</tr>
<tr>
<td>Provides context [6]</td>
<td>Pattern X and Pattern Y can be applied sequentially.</td>
<td>Yes</td>
</tr>
</tbody>
</table>

Fig. 1. Inter-pattern relationships
We use only the partially-ordered relationships because a unordered relationship cannot determine its direction. To use the unordered relationships in addition to the partially-ordered relationships, we should determine a unordered relationship as two opposed partially-ordered relationships. This assumption equates the abstraction levels of the two patterns at the both ends of the unordered relationship. Therefore most of patterns finally have a same abstraction level.

2.1 Intuitive explanation of the proposed metric

By an intuitive reasoning, the reference count of a pattern means the total number of patterns that the pattern can refer transitively. Backward reference count of a pattern means the total number of patterns that can refer the pattern transitively. In Figure 1, ellipses indicate patterns, arrows indicate partially-ordered inter-pattern relationships. For example, MVC pattern transitively refers six other patterns, so reference count of MVC patterns is six, and backward reference count of MVC pattern is zero because no pattern refers the MVC pattern. In the same way, the reference count of Composite pattern is two, and backward reference count is one.

Patterns that use other patterns do not describe details in its solution and delegate details into other patterns. Reversely, a pattern that is used by other patterns treats details delegated from other patterns. The metric score of a pattern is a difference between the reference count and the backward reference count of the pattern. In the example shown in Figure 1, the metric score of MVC pattern is six, and of the Composite pattern is one. Therefore, developers can think that the MVC pattern is more suitable for architectural design.

2.2 Formal definition of the proposed metric

The reference count of a pattern means the total number of patterns that the pattern can refer transitively on the graph. The graph is composed of patterns (vertices) and inter-pattern relationships (edges). Backward reference count of a pattern means the total number of patterns that can refer the pattern transitively on the graph.

The set of $N$ patterns for which we want to calculate the metric score is represented as $P$.

$$P = \{p_1, p_2, \ldots, p_n\}, n \in N.$$

The partially-ordered relationship between a pattern $p_1$ and another pattern $p_2$, $p_1, p_2 \in P$, is represented as $\langle p_1, p_2 \rangle$. Therefore, the set of the relationships $R$ is represented as

$$R \subset P \times P.$$
Note that $\times$ denotes the direct product of two sets. $(P, R)$ is a directed graph. $R^+$ is a transitive closure on $R$. $R^+$ is defined as below:

$$R_1 \circ R_2 = \{ (p_1, p_3) | \exists p_2 \in P ( (p_1, p_2) \in R_1 \land (p_2, p_3) \in R_2 ) \}.$$  

$$R^1 = R.$$  

$$R^{n+1} = R^n \circ R.$$  

$$R^+ = \bigcup_{i=1}^{\infty} R^i.$$  

Note that $\land$ means "and", $\in$ means inclusion of the left-side argument by the right-side argument. At the last line of the above equations, $\bigcup_{i=1}^{\infty}$ means the union of the sets $R^1, R^2, \ldots, R^\infty$.

In addition, the set of patterns that can be retrieved transitively from a certain pattern $p$ is a descendant of $p$, represented as $D(p)$. The set of patterns that a certain pattern $p$ can be retrieved transitively are ancestral of $p$, represented as $A(p)$.

$$D(p) = \{ p_0 | p_0, p \in P \land (p_0, p) \in R^+ \} \subset P.$$  

$$A(p) = \{ p_0 | p, p_0 \in P \land (p, p_0) \in R^+ \} \subset P.$$  

A pattern that has many ancestors tends to be a part of other patterns. A pattern that has many descendants tends to use other patterns. Where $|D(p)|$ denotes the number of patterns included in $D(p)$, and $|A(p)|$ denotes same of $A(p)$, the abstraction level of a certain pattern $p$ is defined as:

$$a(p) = |D(p)| - |A(p)|.$$  

### 2.3 Visualization

Developers cannot understand intuitively only using abstraction levels as plain values. In this section, we propose a visualization technique that uses the above-mentioned abstraction level.

In this technique, patterns with larger $a(p)$ should be positioned above, patterns with smaller $a(p)$ should be positioned below. Position in horizontal axis indicates nothing. In Figure 2, proposed visualization technique positions GoF’s design patterns. Ellipses indicate patterns and arrows indicate partially-ordered inter-pattern relationships. The abstraction level $a(p)$ is used as a hint to position each pattern.

### 3 Experimentation

In order to experiment the metric and visualization techniques, we built a tool that calculates and presents abstraction level of each pattern visually using Java and Graphviz[7]. The results of experiments are in Figure 2 and 3.
In Figure 2, we used "Uses", "Refines" and "Provides context" relationships. The abstraction level of each pattern is calculated according to the method described in Section 2.2. The figure shows that Interpreter pattern and Abstract Factory pattern have higher abstraction level. Actually, the Interpreter pattern refers many other patterns, such as Visitor pattern, Iterator pattern and Composite pattern, directly or indirectly. In the opposite side of that, the figure also shows that Prototype pattern and Singleton pattern have lower abstraction level. Actually, the Prototype and Singleton patterns are referred directly or indirectly by many other patterns directly or indirectly. Using the proposed visualization technique, shown in Figure 2, developers can easier understand that some patterns are close to architectural patterns, and other some patterns are close to idioms.

In Figure 3, we performed a similar analysis on GoF’s design patterns and PoSA’s patterns. Some architectural patterns, such as Layers pattern and Pipes and Filters pattern, are positioned at the top of the figure. It means they have highest abstraction level in shown patterns. Interestingly, Interpreter pattern (a kind of design pattern) is positioned above Broker pattern (a kind of architectural pattern). In the middle of Figure 3, patterns belonging to each pattern catalog are mixed. Patterns can be connected if there are relationships of two patterns from each pattern catalog.

The abstraction level and its visualization cannot be obtained without the proposed metric. Moreover, the developer can apply the proposed metric to a set of patterns, possibly from different catalogs, as we have exemplified.
Fig. 3. A pattern map of GoF’s design patterns and Buschmann’s patterns. Vertical position depends on the score $a(p)$. 

[Diagram showing relationships between design patterns and Buschmann’s patterns, with vertical positions indicating scores.]
4 Related work

Buschmann et al. proposed a classification of patterns: architectural patterns, design patterns, idioms [1]. This classification is based on abstraction level, however, we think it is too course-grained. The abstraction levels of patterns seem to be consecutive. Our metric can classify patterns into consecutive categories.

Martin proposed two metrics on packages [8], such as Afferent Couplings (Ca) and Efferent Couplings (Ce). Our metric and Martin’s OO-metrics have a similar part on the abstract structure of patterns/packages, however, our metric is for software patterns. Though our metric is defined as a very simple subtraction, Martin’s metrics use a more complex calculation, such as a division.

Cutumisu et al. have proposed four metrics of pattern catalogs: usage, coverage, utility and precision [9]. Those metrics use the number of patterns in a pattern catalog and the number of adapted/unadapted instances of patterns. In contrast, our metric uses partially-ordered inter-pattern relationships.

There is a lot of research about inter-pattern relationships [4-6, 1]. Especially, Noble discussed finely [5]. Noble has surveyed inter-pattern relationships and has roughly classified into three categories, such as Use, Refine, Conflict. The Use and Refine relationships are partially-ordered, but the Conflict relationship is unordered. Since our metric is based on partially-ordered relationships, the metric works on Use and Refine relationships.

5 Conclusion

There is a wide variation in software design’s abstraction level from architecture to detailed design near implementation. However, there are only three-level classifications such as architectural patterns, design patterns, idioms. A pattern catalog can contain patterns with different abstraction levels, however, they are not explicitly considered. Therefore, it is difficult for developers to consider design patterns close to architectural patterns, such as the considered Interpreter pattern.

In this paper, we proposed a metric to measure abstraction level of each pattern, based on partially-ordered inter-pattern relationships. The advantages and disadvantages of the proposed metric are the following:

- (Advantage) The metric can be applied to mixed pattern catalogs because the method only uses inter-pattern relationships.
- (Advantage) The metric scores can be used as a hint to position patterns in a pattern map.
- (Disadvantage) The metric score is a relative value, so there is not possible to compare scores calculated from different sets of patterns.
- (Disadvantage) Before applying the metric, the analyzer has to obtain inter-pattern relationships on the targeted set of patterns.

In the future, we plan to perform experiments on other sets of patterns. We also plan to make the metric scores normalized using a statistical technique, such as standard deviation.
References

2. Eric Gamma, Richard Helm, Ralph Johnson, and John Vlissides. *Design Patterns: Elements of Reusable Object-Oriented Software*. Addison-Wesley, 1994.